	Notice of References Cited	Application/Control No. 10/535,068	Applicant(s)/Patent Under Reexamination OKOCHI, TAKAYUKI	
		Examiner MEKONEN BEKELE	Art Unit 2624	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,281,814	08-2001	Sasaoka et al.	341/50
*	B	US-5,801,305	09-1998	Kawai et al.	73/146.2
*	C	US-5,667,244	09-1997	Ito et al.	280/735
*	D	US-6,675,140	01-2004	Irino et al.	704/203
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Takayuki et al., Application of Pattern Analysis to - DendrochronologyTakay uki OKOCHZ,- Tree-ring Recognition by Wavelets; International Congress of Imaging Science 13 May 2002, Tokyo page 441 to 442
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.